

| Referenčna oznaka | Naslov |
|-------------------|--|
| 110/1291/NP | PNW 110-1291 ED1: Durability test methods for electronic displays - Part 2-21: Environmental tests- Test methods for heat and humidity |
| 111/610/NP | PNW 111-610 ED1: Sustainable management of waste electrical and electronic equipment (e-waste). |
| 111/611/NP | PNW TS 111-611 ED1: Material declaration for products of and for the electrotechnical industry: Guidance for the implementation of IEC 62474. |
| 116/494/NP | PNW 116-494 ED1: Lithium-Ion Batteries and Charging Systems - Safety |
| 17C/767/NP | Replaced by 17C/767A/NP |
| 17C/767A/NP | This document, 17C/767/NP, has been withdrawn. |
| 23B/1349/NP | PNW 23B-1349 ED1: ENERGY PLUG AND ENERGY SOCKET OUTLETS |
| 3/1473/NP | PNW 3-1473 ED1: Industrial systems, installations and equipment and industrial products -- Structuring principles and reference designations -- Part 101: Power plants -- Modelling concepts and guidelines |
| 31M/155/NP | PNW 31M-155 ED1: Flame arresters — Performance requirements, test methods and limits for |
| 31M/156/NP | PNW 31M-156 ED1: Explosion venting devices |
| 42/390/NP | PNW 42-390 ED1: High-voltage test techniques - Dielectric loss measurements |
| 45B/975/NP | PNW 45B-975 ED1: General technical requirements for millimeter wave holographic imaging body scanner |
| 46A/1464/NP | PNW 46A-1464 ED1: Coaxial communication cables Part 1-126: Electrical test methods – Corona extinction voltage |
| 46F/551/NP | PNW 46F-551 ED1: RADIO-FREQUENCY CONNECTORS – Part 1-7: Electrical test methods - Voltage standing wave ratio for a single connector by double connector method |
| 47/2683/NP | PNW 47-2683 ED1: Semiconductor devices - Measurement and evaluation methods of kinetic energy harvesting devices under practical vibration environment - Part 2: Human arm swing motion |
| 47/2685/NP | PNW 47-2685 ED1: Semiconductor devices – Non-destructive recognition criteria of defects in silicon carbide homoepitaxial wafer for power devices – Part 4: Procedure for identifying and evaluating defects using a combined method of optical inspection and photoluminescence |

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| 47D/927/NP | PNW 47D-927 ED1: Future 63xxx-3 Ed.1: Thermal standardization on semiconductor packaging – Part 3: Thermal circuit simulation models of semiconductor packages for transient analysis |
| 47F/375/NP | PNW 47F-375 ED1: Semiconductor devices – Micro-electromechanical devices – Part 43: Test method of electrical characteristics after cyclic bending deformation for flexible electro-mechanical devices |
| 69/741A/NP | PNW 69-741 ED1: Local Charging station management systems and Local Energy Management Systems network connectivity and information exchange |
| 82/1860/NP | PNW TS 82-1860 ED1: Fire test for concentrator PV modules |
| 9/2686/NP | PNW 9-2686 ED1: Railway applications – Fixed installations – Electronic power converters - Part 2-2: DC Applications - Controlled converters |
| 91/1706/NP | PNW 91-1706 ED1: Endurance test methods for die attach materials – Part 1: General specification |
| 91/1707/NP | PNW 91-1707 ED1: Endurance test methods for die attach materials – Part 5: Temperature cycling test methods and reliability performance index for die attach materials (system soldering interconnection) applied to module type power electronic devices |
| 91/1709/NP | PNW 91-1709 ED1: Endurance test methods for die attach materials – Part 3: Power cycling test method and reliability performance index for die attach materials applied to discrete type power electronic devices |
| JTC1-SC41/196A/NP | PNW JTC1-SC41-196 ED1: Internet of Things (IoT) - Data format, value and coding |
| JTC1-SC41/200/NP | PNW JTC1-SC41-200 ED1: Internet of Things (IoT) – Data exchange platform for IoT services – Part 2: Transport interoperability between nodal points |
| JTC1-SC25/3003/NP | PNW JTC1-SC25-3003 ED1: ISO/IEC 10192-4-2: Information technology – Home Electronic System (HES) interfaces – Part 4-2: Common user interface and cluster-to-cluster interface to support interworking among home cluster systems – Interfaces, services and objects |
| 82/1860/NP | PNW TS 82-1860 ED1: Fire test for concentrator PV modules |
| JTC1-SC25/3004/NP | PNW JTC1-SC25-3004 ED1: ISO/IEC 10192-4-3: Information technology – Home Electronic System (HES) interfaces – Part 4-3: Common user interface and cluster-to-cluster interface to support interworking among home cluster systems – Messaging |
| 9/2686/NP | PNW 9-2686 ED1: Railway applications – Fixed installations – Electronic power converters - Part 2-2: DC Applications - Controlled converters |